Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
09/747,289	KIM ET AL.
Examiner	Art Unit
Thien D. Tran	2665

	SEARCHED		
Class	Subclass	Date	Examiner
370	230	5/18/2005	тт
	320	5/18/2005	тт
	329	5/18/2005	тт

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
370	329	5/18/2005	тт	
	320	5/18/2005	TT	

SEAR((INCLUDING SE	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
East	5/18/2005	тт	
East	5/18/2005	тт	